Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/789,819	SHINKAWA ET	AL.
Examiner	Art Unit	
Shih-wen Hsieh	2861	

SEARCHED			
Class	Subclass	Date	Examiner
347	updated	8/23/2006	swн

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
_			
	<u> </u>		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
USPGPUB text search (see attached)	8/23/2006	swh	
		:	